

## MOSFET Maximum Ratings T<sub>J</sub> = 25°C unless otherwise noted.

Symbol	Parameter		Ratings	Units	
V <sub>DSS</sub>	Drain-to-Source Voltage		40	V	
V <sub>GS</sub>	Gate-to-Source Voltage		±20	V	
	Drain Current - Continuous (V <sub>GS</sub> =10) (Note 1)	T <sub>C</sub> =25°C	240	^	
D	Pulsed Drain Current	T <sub>C</sub> = 25°C	See Figure 4	— A	
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 2)	737	mJ	
P <sub>D</sub>	Power Dissipation		357	W	
	Derate Above 25°C		2.38	W/ <sup>o</sup> C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature		-55 to + 175	°C	
R <sub>θJC</sub>	Thermal Resistance, Junction to Case		0.42	°C/W	
R <sub>0JA</sub>	Maximum Thermal Resistance, Junction to Ambient	(Note 3)	43	°C/W	

## Notes:

1: Current is limited by bondwire configuration.

2: Starting  $T_J = 25^{\circ}C$ , L = 0.36 mH,  $I_{AS} = 64$ A,  $V_{DD} = 40$ V during inductor charging and  $V_{DD} = 0$ V during time in avalanche.

3: R<sub>0JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>0JC</sub> is guaranteed by design, while R<sub>0JA</sub> is determined by the board design. The maximum rating presented here is based on mounting on a 1 in<sup>2</sup> pad of 2oz copper.

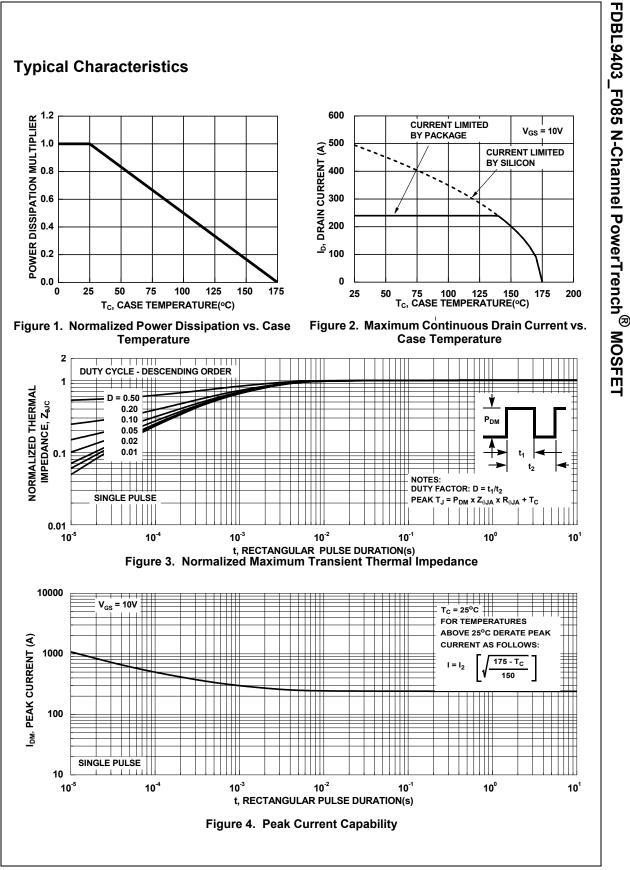
## Package Marking and Ordering Information

Device Marking	Device	Package			
FDBL9403	FDBL9403_F085	MO-299A	-	-	-

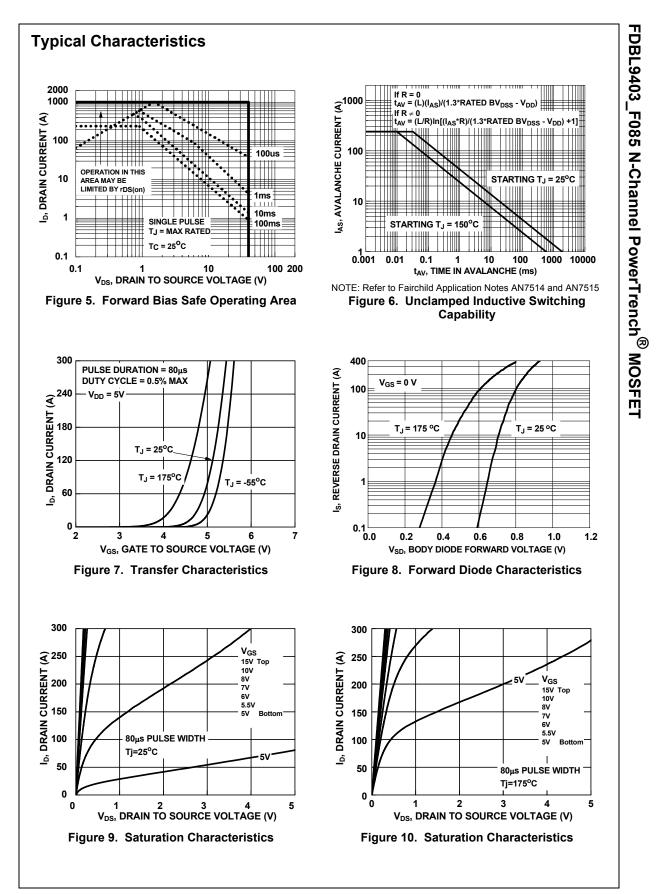
Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units
Off Cha	racteristics						
B <sub>VDSS</sub>	Drain-to-Source Breakdown Voltage	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V		40	-	-	V
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>DS</sub> =40V,		-	-	1	μA mA
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>GS</sub> = ±20V		-	-	±100	nA
On Cha	racteristics			-			
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS}$ = $V_{DS}$ , I		2.0	3.3	4.0	V
	Drain to Source On Resistance	I <sub>D</sub> = 80A,		-	0.65	0.90	mΩ
R <sub>DS(on)</sub>		V <sub>GS</sub> = 10V	T <sub>J</sub> = 175 <sup>o</sup> C (Note 4)	-	1.10	1.50	mΩ
C <sub>iss</sub> C <sub>oss</sub>	Input Capacitance Output Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V, f = 1MHz		-	12000 3260	-	pF pF
				-	3260	-	•
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1101112		-	442	-	pF
R <sub>g</sub>	Gate Resistance	f = 1MHz		-	3.3	-	Ω
Q <sub>g(ToT)</sub>	Total Gate Charge at 10V	V <sub>GS</sub> = 0 to 1	0V V <sub>DD</sub> = 32V	-	144	188	nC
Q <sub>g(th)</sub>	Threshold Gate Charge	$V_{GS} = 0 \text{ to } 2^{2}$	V I <sub>D</sub> = 80A	-	22	26	nC
Q <sub>gs</sub>	Gate-to-Source Gate Charge			-	66	-	nC
Q <sub>gd</sub>	Gate-to-Drain "Miller" Charge			-	16	-	nC
	ng Characteristics				_	160	20
t <sub>on</sub> ⁺		_	-	-	- 42	162	ns
t <sub>d(on)</sub> t	Turn-On Delay Rise Time	$V_{DD}$ = 20V, I <sub>D</sub> = 80A, $V_{GS}$ = 10V, R <sub>GEN</sub> = 6 $\Omega$		-	42 73	-	ns ns
t <sub>r</sub>	Turn-Off Delay			-	83	-	ns
t <sub>d(off)</sub> t	Fall Time			-	50	-	ns
t <sub>f</sub>	Turn-Off Time			-		279	ns
t <sub>off</sub>				-	-	219	115
Drain-S	ource Diode Characteristics						
V <sub>SD</sub>	Source-to-Drain Diode Voltage	I <sub>SD</sub> =80A, V <sub>GS</sub> = 0V		-	-	1.25	V
	<b>.</b>	I <sub>SD</sub> = 40A, V		-	-	1.2	V
t <sub>rr</sub>	Reverse-Recovery Time	$I_F = 80A$ , $dI_{SD}/dt = 100A/\mu s$ , $V_{DD}=32V$		-	111	129	ns
Q <sub>rr</sub>	Reverse-Recovery Charge			-	178	214	nC

Note:

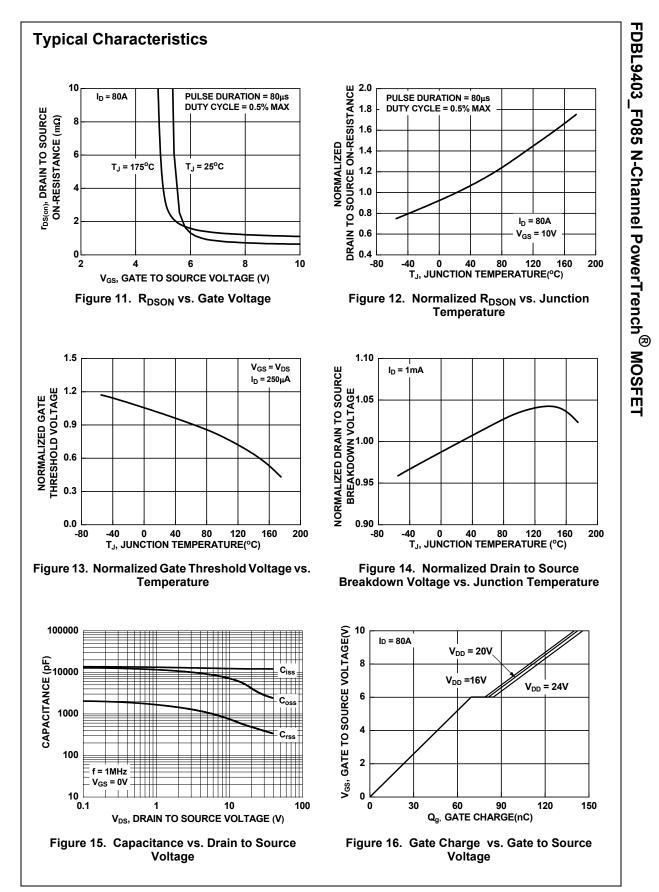
4: The maximum value is specified by design at  $T_J$  = 175°C. Product is not tested to this condition in production.



FDBL9403\_F085 Rev. C1



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Obsolete

Not In Production

Datasheet contains specifications on a product that is discontinued by Fairchild

Semiconductor. The datasheet is for reference information only.